

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Fixed resistors for use in electronic equipment –
Part 9-1: Blank detail specification: Fixed surface mount resistor networks with
individually measurable resistors – Assessment level EZ**

**Résistances fixes utilisées dans les équipements électroniques –
Partie 9-1: Spécification particulière cadre: Réseaux de résistances fixes montés
en surface avec des résistances mesurables individuellement – Niveau
d'assurance EZ**



THIS PUBLICATION IS COPYRIGHT PROTECTED

Copyright © 2003 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester.

If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

Droits de reproduction réservés. Sauf indication contraire, aucune partie de cette publication ne peut être reproduite ni utilisée sous quelque forme que ce soit et par aucun procédé, électronique ou mécanique, y compris la photocopie et les microfilms, sans l'accord écrit de la CEI ou du Comité national de la CEI du pays du demandeur.

Si vous avez des questions sur le copyright de la CEI ou si vous désirez obtenir des droits supplémentaires sur cette publication, utilisez les coordonnées ci-après ou contactez le Comité national de la CEI de votre pays de résidence.

IEC Central Office
3, rue de Varembe
CH-1211 Geneva 20
Switzerland

Tel.: +41 22 919 02 11
Fax: +41 22 919 03 00
info@iec.ch
www.iec.ch

About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigenda or an amendment might have been published.

Useful links:

IEC publications search - www.iec.ch/searchpub

The advanced search enables you to find IEC publications by a variety of criteria (reference number, text, technical committee,...).

It also gives information on projects, replaced and withdrawn publications.

IEC Just Published - webstore.iec.ch/justpublished

Stay up to date on all new IEC publications. Just Published details all new publications released. Available on-line and also once a month by email.

Electropedia - www.electropedia.org

The world's leading online dictionary of electronic and electrical terms containing more than 30 000 terms and definitions in English and French, with equivalent terms in additional languages. Also known as the International Electrotechnical Vocabulary (IEV) on-line.

Customer Service Centre - webstore.iec.ch/csc

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: csc@iec.ch.

A propos de la CEI

La Commission Electrotechnique Internationale (CEI) est la première organisation mondiale qui élabore et publie des Normes internationales pour tout ce qui a trait à l'électricité, à l'électronique et aux technologies apparentées.

A propos des publications CEI

Le contenu technique des publications de la CEI est constamment revu. Veuillez vous assurer que vous possédez l'édition la plus récente, un corrigendum ou amendement peut avoir été publié.

Liens utiles:

Recherche de publications CEI - www.iec.ch/searchpub

La recherche avancée vous permet de trouver des publications CEI en utilisant différents critères (numéro de référence, texte, comité d'études,...).

Elle donne aussi des informations sur les projets et les publications remplacées ou retirées.

Just Published CEI - webstore.iec.ch/justpublished

Restez informé sur les nouvelles publications de la CEI. Just Published détaille les nouvelles publications parues. Disponible en ligne et aussi une fois par mois par email.

Electropedia - www.electropedia.org

Le premier dictionnaire en ligne au monde de termes électroniques et électriques. Il contient plus de 30 000 termes et définitions en anglais et en français, ainsi que les termes équivalents dans les langues additionnelles. Egalement appelé Vocabulaire Electrotechnique International (VEI) en ligne.

Service Clients - webstore.iec.ch/csc

Si vous désirez nous donner des commentaires sur cette publication ou si vous avez des questions contactez-nous: csc@iec.ch.



IEC 60115-9-1

Edition 1.0 2003-10

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Fixed resistors for use in electronic equipment –
Part 9-1: Blank detail specification: Fixed surface mount resistor networks with
individually measurable resistors – Assessment level EZ**

**Résistances fixes utilisées dans les équipements électroniques –
Partie 9-1: Spécification particulière cadre: Réseaux de résistances fixes montés
en surface avec des résistances mesurables individuellement – Niveau
d'assurance EZ**

INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

COMMISSION
ELECTROTECHNIQUE
INTERNATIONALE

PRICE CODE
CODE PRIX



ICS 31.040.10

ISBN 978-2-83220-351-4

**Warning! Make sure that you obtained this publication from an authorized distributor.
Attention! Veuillez vous assurer que vous avez obtenu cette publication via un distributeur agréé.**

INTERNATIONAL ELECTROTECHNICAL COMMISSION

FIXED RESISTORS FOR USE IN ELECTRONIC EQUIPMENT –

**Part 9-1: Blank detail specification:
Fixed surface mount resistor networks
with individually measurable resistors –
Assessment level EZ**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC provides no marking procedure to indicate its approval and cannot be rendered responsible for any equipment declared to be in conformity with an IEC Publication.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

International Standard IEC 60115-9-1 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

This bilingual version (2012-09) corresponds to the monolingual English version, published in 2003-10.

The text of this standard is based on the following documents:

FDIS	Report on voting
40/1345/FDIS	40/1367/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

The French version of this standard has not been voted upon.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

iTeh STANDARD PREVIEW **(standards.iteh.ai)**

[IEC 60115-9-1:2003](https://standards.iteh.ai/catalog/standards/sist/518d9db1-22c6-4c11-94c5-a57f9d004e35/iec-60115-9-1-2003)

<https://standards.iteh.ai/catalog/standards/sist/518d9db1-22c6-4c11-94c5-a57f9d004e35/iec-60115-9-1-2003>

INTRODUCTION

Blank detail specification

A blank detail specification is a supplementary document to the sectional specification and contains requirements for style, layout and minimum content of detail specifications. Detail specifications not complying with these requirements may not be considered as being in accordance with IEC specifications nor shall they be so described.

In the preparation of detail specifications the content of 1.4 of the sectional specification shall be taken into account.

The numbers between square brackets on the first page of the detail specification correspond to the following information which shall be inserted in the position indicated.

Identification of the detail specification

- [1] The "International Electrotechnical Commission" or the National Standards Organization under whose authority the detail specification is drafted.
- [2] The IEC or National Standards number of the detail specification, date of issue and any further information required by the national system.
- [3] The number and issue number of the IEC or national generic specification.
- [4] The IEC number of the blank detail specification.

Identification of the resistor network

- [5] A short description of the type of resistor network.
- [6] Information on typical construction (when applicable).
- [7] Outline drawing with main dimensions which are of importance for interchangeability and/or reference to the national or international documents for outlines. Alternatively, this drawing may be given in an annex to the detail specification.
- [8] Application or group of applications covered and/or assessment level.
- [9] Reference data on the most important properties, to allow comparison between the various resistor network types.

[1]	IEC 60115-9-1-XXX QC 400701XXXXXX	[2]
ELECTRONIC COMPONENTS OF ASSESSED QUALITY IN ACCORDANCE WITH:	IEC 60115-9-1 QC 400701	[4]
[3]	FIXED SURFACE MOUNT RESISTOR NETWORKS WITH INDIVIDUALLY MEASURABLE RESISTORS	[5]
Outline drawing: (see Table 1) (... angle projection)		
[7]		[6]
(Other shapes are permitted within the dimensions given)	Assessment level: EZ	[8]
NOTE For [1] to [9]: see previous page.		

Information on the availability of components qualified to
this detail specification is given in the IEC QC 001005

[9]

FIXED RESISTORS FOR USE IN ELECTRONIC EQUIPMENT –

Part 9-1: Blank detail specification: Fixed surface mount resistor networks with individually measurable resistors – Assessment level EZ

1 General data

1.1 Dimensions, ratings and characteristics

Table 1 – Styles related to dimensions, ratings and characteristics

Style	Rated element dissipation at 70 °C ^{a)}	Rated network dissipation at 70 °C	Limiting element voltage (DC or AC r.m.s.)	Insulation voltage against ambient	Insulation voltage between neighbouring resistors	Dimensions						
						mm						
	W	W	V	V	V	<i>L</i>	<i>W</i>	<i>T</i>	<i>A</i>	<i>B</i>	<i>P</i>	...

^{a)} The detail specification shall specify the conditions under which the rated dissipation applies.

<https://standards.iteh.ai/catalog/standards/sis/518d9db1-22c6-4c11-94c5-a5719d004e35/iec-60115-9-1-2003>

Resistance range¹ ... Ω to ... Ω

Tolerances on rated resistance ± ... %

Climatic category –/–/–/

Stability class ... %

Limits for change of resistance:

– for long-term tests ±(... %R + ... Ω)

– for short-term tests ±(... %R + ... Ω)

Temperature coefficient α: ...10^{–6}/K

¹ The preferred values are those of the E24 and E96 series of IEC 60063.

1.1.1 Derating

Resistors covered by this specification are derated according to the following curve:

(A suitable curve to be included
in the detail specification)

NOTE See also 2.2.3 of the sectional specification.

1.2 Recommended method(s) of mounting (to be inserted)

(See 1.4.2 of IEC 60115-9.)

1.3 Related documents

Generic specification

IEC 60115-1:1999, *Fixed resistors for use in electronic equipment – Part 1: Generic specification*

Sectional specification

IEC 60115-9:2003, *Fixed resistors for use in electronic equipment – Part 9: Sectional specification: Fixed surface mount resistor networks with individually measurable resistors*

[IEC 60115-9-1:2003](https://standards.iteh.ai/catalog/standards/sist/518d9db1-22c6-4c11-94c5-a57f9d004e35/iec-60115-9-1-2003)

1.4 Marking <https://standards.iteh.ai/catalog/standards/sist/518d9db1-22c6-4c11-94c5-a57f9d004e35/iec-60115-9-1-2003>

The marking of the resistors and the package shall be in accordance with the requirements of 2.4 of IEC 60115-1 and 1.4.5 of IEC 60115-9.

The details of the marking of the component and packaging shall be given in full in the detail specification.

1.5 Ordering information

Orders for resistors covered by this specification shall contain, in clear or in coded form, the following minimum information:

- rated element resistance;
- tolerance on rated resistance;
- number and issue reference of the detail specification and style reference;
- packaging instructions.

1.6 Certified records of released lots

Required/non required.

1.7 Additional information (not for inspection purposes)

1.8 Additional or increased severities or requirements to those specified in the generic and/or sectional specification

NOTE Additions or increased requirements should be specified only when essential.

2 Inspection requirements

2.1 Procedures

2.1.1 For qualification approval, the procedure shall be in accordance with 3.2 of IEC 60115-9.

2.1.2 For quality conformance inspection, the test schedule (Table 2) includes sampling, periodicity, severities and requirements. The formation of inspection lots is covered by 3.3.1 of IEC 60115-9.

The following list applies to the test schedules developed in Table 2 and Table 3.

- a) Subclause numbers of tests and performance requirements refer to the generic specification, IEC 60115-1, except for resistance change requirements, which shall be selected from Table 3 of IEC 60115-9, as appropriate.
- b) Number to be tested: sample size as directly allotted to the code letter for *IL* in Table IIA of IEC 60410 (single sampling plan for normal inspection).
- c) In these tables: *p* is the periodicity (in months)
n is the sample size
c is the acceptance criterion (permitted number of non-conforming items)
D indicates a destructive test
ND indicates a non-destructive test
IL is the inspection level
- d) 100 % testing shall be followed by re-inspection by sampling in order to monitor outgoing quality level by non-conforming items per million (ppm). The sampling level shall be established by the manufacturer. For the calculation of $\times 10^{-6}$ values, any parametric failure shall be counted as a non-conforming item. In case one or more non-conforming items occur in a sample, this lot shall be rejected.
- e) If one non-conforming item is obtained, all the tests of the subgroup shall be repeated on a new sample and then no further non-conforming items are permitted. Release of product may continue during repeat testing.

Table 2 – Test schedule for quality conformance inspection: lot-by-lot

Subclause number and test (see 2.1.2, list item a of this specification)	D or ND	Conditions of test (see 2.1.2, list item a of this specification)	IL	n	c	Performance requirements (see 2.1.2, list item a of this specification)
GROUP A INSPECTION (lot-by-lot) Subgroup A0 4.5 Resistance	ND		100 % (see 2.1.2, list item c of this specification)			As in 4.5.2
Subgroup A1 4.4.1 Visual examination 4.4.2 Dimensions (gauging)	ND		S-4	1)	0	As in 4.4.1 As specified in the detail specification
GROUP B INSPECTION (lot-by-lot) Subgroup B1 4.7 Voltage proof (insulated resistors only) Voltage proof between neighbouring resistors	ND	Method: ... Insulation resistance (insulated resistors only) Voltage: ... V	S-3	1)	0	As in 4.7.3 ≥ 100 MΩ As in 4.7.3
Subgroup B2 4.17 Solderability	D	Aging, if applicable	S-3	1)	0	As in 4.17.5
Subgroup B3 4.31 Mounting 4.13 Overload (in the mounted state) 4.30 Solvent resistance of the marking (if applicable)	D	Substrate material and spacing: see 2.3.2 of IEC 60115-9 The applied voltage shall be 2,5 times the rated voltage or twice the limiting element voltage, whichever is the less severe Duration: 2 s Visual examination Resistance Solvent: ... Solvent temperature: ... Method 1 Rubbing material: cotton wool Recovery: ...	S-3	1)	0	No visible damage $\Delta R \leq \pm(\dots \%R + \dots \Omega)$ Legible marking

1) See 2.1.2, list item b of this specification.